

## **ZVN4525GTA-VB Datasheet** N-Channel 250 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	250				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	2.0			
Q <sub>g</sub> (Max.) (nC)	8.2				
Q <sub>gs</sub> (nC)	1.8				
Q <sub>gd</sub> (nC)	4.5				
Configuration	Single				

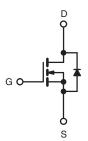
#### **FEATURES**

- Surface mount
- Available in tape and reel
- Dynamic dV/dt rating
- Repetitive avalanche rated
- · Fast switching
- Ease of paralleling
- Simple drive requirements









N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (To	; = 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	250	V	
Gate-Source Voltage			$V_{GS}$	± 20	7 °	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C		0.79		
		T <sub>C</sub> = 100 °C	I <sub>D</sub>	0.50	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	6.3		
Linear Derating Factor				0.025	W/°C	
Linear Derating Factor (PCB Mount) <sup>e</sup>				0.017		
Single Pulse Avalanche Energy b			E <sub>AS</sub>	50	mJ	
Repetitive Avalanche Current a			I <sub>AR</sub>	0.79	Α	
Repetitive Avalanche Energy a			E <sub>AR</sub>	0.31	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		-	3.1	14/	
Maximum Power Dissipation (PCB Mount) e	T <sub>A</sub> =	25 °C	$P_{D}$	2.0	W	
Peak Diode Recovery dV/dt <sup>c</sup>	•		dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	1 00	
Soldering Recommendations (Peak Temperature)	for 10 s		_	300	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 128 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 0.79$  A (see fig. 12). c.  $I_{SD} \le 2.7$  A,  $dI/dt \le 65$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	-	60	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	40		

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEC	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static	STMBOL	IES	SI CONDITIONS	IVIIIV.	ITP.	IVIAA.	UNIT
Drain-Source Breakdown Voltage	V <sub>DS</sub>	Voc	= 0 V, I <sub>D</sub> = 250 μA	250	_	l -	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>		ce to 25 °C, I <sub>D</sub> = 1 mA	-	0.39	_	V/°C
Gate-Source Threshold Voltage			= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	0.59	4.0	V
	V <sub>GS(th)</sub>	-		2.0			
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$	_	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		$V_{DS} = 250 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$		-	25 250	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 0.47 A <sup>b</sup>	-	2.0	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 0.47 A	0.50	-	-	S
Dynamic				I.	•	•	•
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$ ,	-	140	-	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		-	42	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1	f = 1.0 MHz, see fig. 5		9.6	-	
Total Gate Charge	Qq	$V_{GS} = 10 \text{ V}$ $I_D = 2.7 \text{ A}, V_{DS} = 200 \text{ V},$ see fig. 6 and 13 b		-	-	8.2	nC
Gate-Source Charge	Q <sub>gs</sub>			-	-	1.8	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	4.5	
Turn-On Delay Time	t <sub>d(on)</sub>		ı	-	7.0	-	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 125 V, $I_{D}$ = 2.7 A, $R_{g}$ = 24 $\Omega$ , $R_{D}$ = 45 $\Omega$ , see fig. 10 $^{b}$		-	7.6	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	16	-	
Fall Time	t <sub>f</sub>			_	7.0	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	
Internal Source Inductance	L <sub>S</sub>			-	6.0	-	nH
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym	MOSFET symbol		-	0.79	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	6.3	Α
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 0.79  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$		-	-	2.0	٧
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 2.7 \text{ A}, dI/dt = 100 \text{ A/}\mu\text{s}^b$		-	190	390	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.64	1.3	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic to	ırn-on time is negligible (turn	-on is dor	minated h	v L c and	[ P)

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

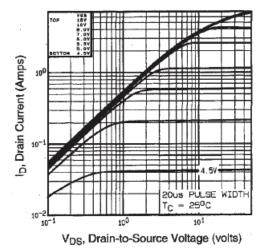


Fig. 1 - Typical Output Characteristics

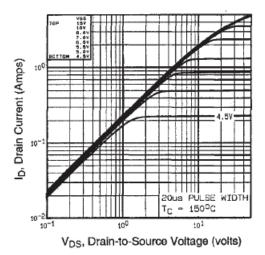


Fig. 2 - Typical Output Characteristics

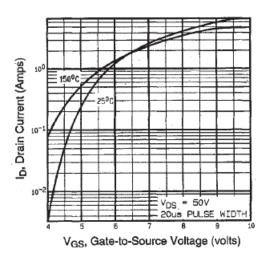


Fig. 3 - Typical Transfer Characteristics

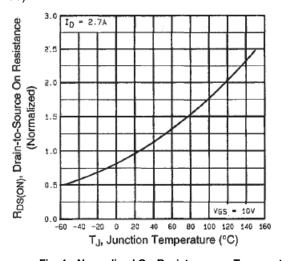


Fig. 4 - Normalized On-Resistance vs. Temperature

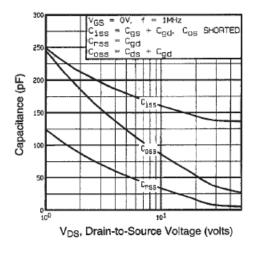


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

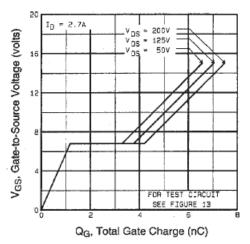


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



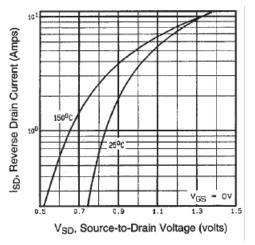


Fig. 7 - Typical Source-Drain Diode Forward Voltage

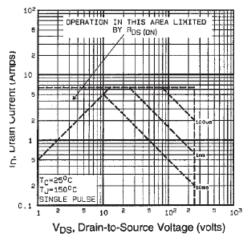


Fig. 8 - Maximum Safe Operating Area

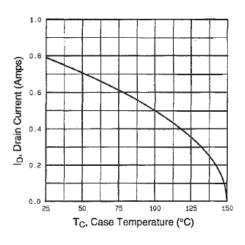


Fig. 9 - Maximum Drain Current vs. Case Temperature

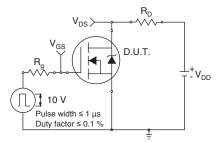


Fig. 10a - Switching Time Test Circuit

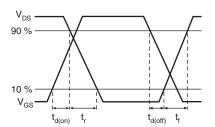


Fig. 10b - Switching Time Waveforms

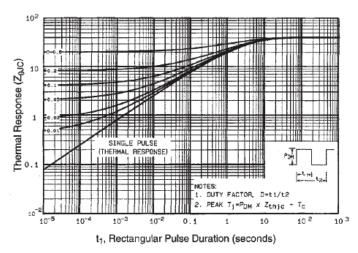


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



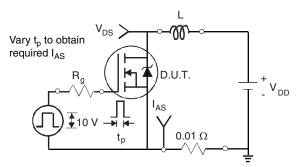


Fig. 12a - Unclamped Inductive Test Circuit

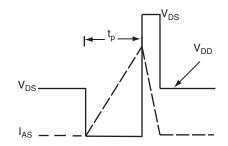


Fig. 12b - Unclamped Inductive Waveforms

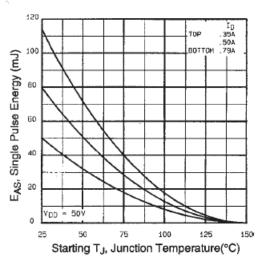


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

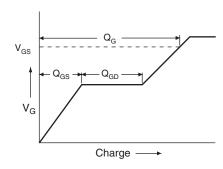


Fig. 13a - Basic Gate Charge Waveform

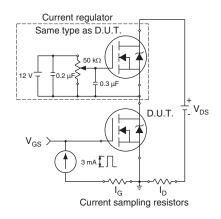
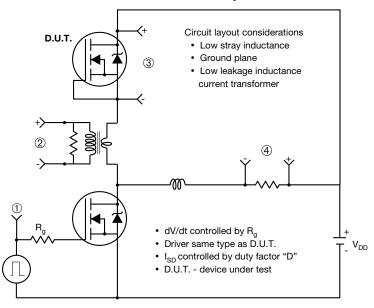


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



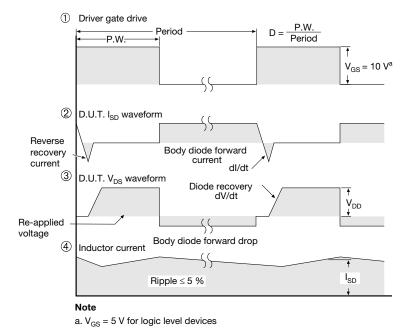
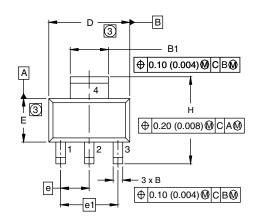
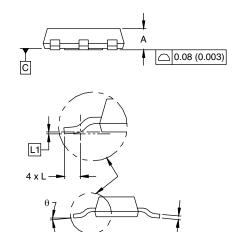


Fig.14 - For N-Channel



### **SOT-223 (HIGH VOLTAGE)**





	MILLI	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	1.55	1.80	0.061	0.071	
В	0.65	0.85	0.026	0.033	
B1	2.95	3.15	0.116	0.124	
С	0.25	0.35	0.010	0.014	
D	6.30	6.70	0.248	0.264	
E	3.30	3.70	0.130	0.146	
е	2.30 BSC		0.0905 BSC		
e1	4.60 BSC		0.181 BSC		
Н	6.71	7.29	0.264	0.287	
L	0.91	-	0.036	-	
L1	0.061 BSC		0.0024 BSC		
θ	-	10'	-	10'	

ECN: S-82109-Rev. A, 15-Sep-08

DWG: 5969

#### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension do not include mold flash.
- 4. Outline conforms to JEDEC outline TO-261AA.



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